



**Specifications** 

SYSTEM

6306-0360-04 system with full enclosure ZYGO P/N

> 6306-0360-05 system with 1/2 height

enclosure

Measurement 3D coherence scanning interferometry, Technique

SureScan<sup>™</sup> technology

Precision Piezo drive with Closed loop Scanner

capacitance gauge control and

crash protection

Objectives 1.0X - 100X magnification;

> Standard and long working distance; See the Nexview & NewView 9000 Series

Objective Chart for more details

Objective Mounting **Options** 

Illuminator

· Single objective dovetail

Manual Encoded 4-position turret

Motorized 4-position turret

Optical Zoom Motorized 3-position encoded zoom

• 0.5X, 1.0X, 2.0X included

• 0.75X, 1.5X optional

Field of View Objective and zoom selectable from

0.04 x 0.04 mm to 17.49 x 17.49 mm; Integrated field stitching for larger areas

Proprietary solid-state white light source

with software-selectable field stop,

aperture stop and spectral filters

Measurement Selectable 1600 x 1200, 1000 x 1000, Array

1000 x 600, 1000 x 200

Part Viewing Selectable Monochrome imaging with

available fringe-free viewing mode

Motorized manual or auto focus with Part Focus

Finder and Smart Setup Technology

**Z-Drive** (Focus) Stage

150 mm range with 0.1 µm resolution

Part Stage Encoded linear motor drive with

650 x 650 mm XY travel range

Split axis gantry style; X-stage translates

Configuration Head; Y-stage translates the sample Custom vacuum sample holders up to Sample Holder

650 x 650 mm available

System Controller

Stage

i7 class PC with 1080P display

Software ZYGO Mx software running under Microsoft

Windows 10 (64-bit)

### **PHYSICAL**

Dimensions System with enclosure: (HWD) 166 x 140 x 164 cm

> Weight System: 1830 kg

> > System with enclosure: 1955 kg

# **UTILITY REQUIREMENTS**

Vacuum

Input Voltage Compressed Air for isolation

100 to 240 VAC, 50/60 Hz

4.1 to 5.5 bar (60 to 80 psi); dry and

filtered; 1/4 in. input

Optional from a customer supplied source, based on part stage requirements

Specifications subject to change without prior notice.

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#### PERFORMANCE

Vertical Scan Range 150 µm with precision Piezo drive;

20 mm with extended scan

Surface Topography

Repeatability of RMS(2)

Repeatability(1)

0.01 nm

0.12 nm

Optical Lateral Resolution(3)

0.34 µm (100X objective)

0.04 µm (100X objective 2X zoom) Spatial Sampling

Maximum Data Scan Speed(4)

53 µm/sec @ 1600 x 1200 69 µm/sec @ 1000 x 1000 107 μm/sec @ 1000 x 600 171 µm/sec @ 1000 x 200

Step Height Repeatability(5)

0.1%

Step Height Accuracy<sup>(6)</sup>

0.3%

#### TEST PART CHARACTERISTICS

Material Opaque, transparent, coated,

uncoated, specular, rough

Maximum Sample Height

260 mm under X axis Crossbeam 329 mm under typ. objective focus

Maximum Surface Slope 55° – smooth part @ 100X 85° – scattering surface

Sample Reflectivity

0.05% - 100%

## **ENVIRONMENTAL REQUIREMENTS**

Temperature

15 to 30°C with rate of change

<1.0°C per 15 min

Humidity

5 to 95% relative, noncondensing

Vibration Isolation

Included and required for vibration in the range of 1 Hz to 120 Hz

Vibration Criterion

VC-C or better

**Acoustic Criterion** 

NC30 or better

### **FOOTNOTES**

Performance specifications under laboratory conditions using standard specimens, according to ISO 25178-601, 25178-604 and 5436-1.

- Surface Topography Repeatability for CSI mode, 1-sec acquisition, full FOV with 3x3 median filter, in a laboratory environment.
- (2) Repeatability of the RMS surface roughness parameter Sq, under the same conditions as for (1). Note that the repeatability of the Sq is sometimes referred to informally as "vertical resolution."
- (3) Lateral Resolution=Sparrow criterion, objective dependent.
- Data scan speed depends on the measurement array and data acquisition mode.
- 1- $\sigma$  Step height repeatability verified using 1.8 μm and 24 μm ZYGO certified step height standards.
- (6) Instrument contribution to uncertainty for step height measurements using the piezo drive.

Distribution in the UK & Ireland



Characterisation, Measurement & **Analysis** 

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